

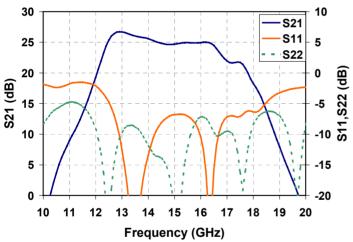
Ku Band 2 Watt Packaged Amplifier

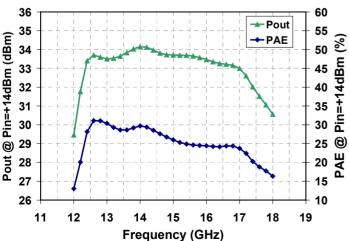
TGA2510-EPU-SG



Preliminary Measured Performance

Bias Conditions: Vd=7.5V Id=650mA





Key Features and Performance

- 33.5 dBm Midband Psat
- 25 dB Nominal Gain
- 7 dB Typical Input Return Loss
- 10 dB Typical Output Return Loss
- 12.5 17 GHz Frequency Range
- Directional Power Detector with Reference
- 0.25µm pHEMT 3MI Technology
- Bias Conditions: 7.5V, 650mA
- Package Dimensions:
 9.4 x 6.4 x 1.8 mm
 (0.370 x 0.250 x 0.071 inches)

Primary Applications

- VSAT
- Point to Point



Advance Product Information October 30, 2003

TGA2510-EPU-SG

TABLE I MAXIMUM RATINGS

| Symbol | Parameter | Value | Notes |
|------------------|-----------------------------------|---------------|----------------------------------|
| V_D | Drain Voltage | 8 V | <u>1</u> / <u>2</u> / |
| V _G | Gate Voltage Range | -5V to 0V | <u>1</u> / |
| I _D | Drain Supply Current (Quiescent) | 1300 mA | <u>1</u> / <u>2</u> / |
| I _G | Gate Supply Current | 18 mA | <u>1</u> / |
| P _{IN} | Input Continuous Wave Power | 24 dBm | <u>1</u> / <u>2</u> / |
| P_D | Power Dissipation | 6.15 W | <u>1</u> / <u>2</u> / <u>3</u> / |
| T _{CH} | Operating Channel Temperature | 150 °C | <u>4</u> / |
| T _M | Mounting Temperature (30 Seconds) | 320 °C | |
| T _{STG} | Storage Temperature | -65 to 150 °C | |

- 1/ These ratings represent the maximum operable values for this device
- **2/** Combinations of supply voltage, supply current, input power, and output power shall not exceed P_D at a package base temperature of 70°C
- 3/ When operated at this bias condition with a baseplate temperature of 70°C, the MTTF is reduced to 1.0E+6 hours
- **4/** Junction operating temperature will directly affect the device median time to failure (MTTF). For maximum life, it is recommended that junction temperatures be maintained at the lowest possible levels.

TABLE II THERMAL INFORMATION

| Parameter | Test Conditions | T _{CH} (°C) | R _{⊕JC} (°C/W) | MTTF (hrs) |
|--|---|----------------------|----------------------------|---------------|
| R _{⊝JC} Thermal Resistance (Channel to Backside of Package) | $V_D = 7.5V$ $I_D = 650$ mA $P_{DISS} = 4.88W$ $T_{BASE} = 70$ °C | 132.3 | 12.8 | 4.8E+6 |



Advance Product Information October 30, 2003

TGA2510-EPU-SG

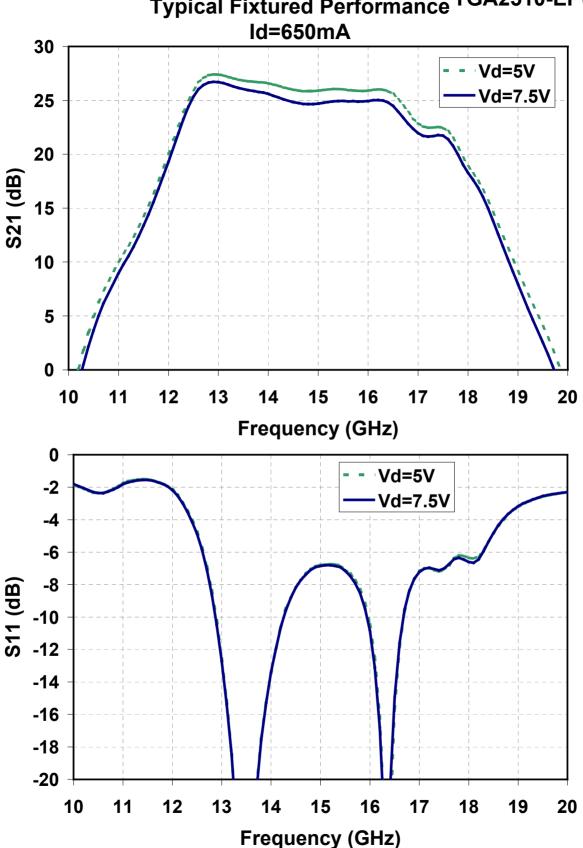
TABLE III RF CHARACTERIZATION TABLE ($T_A = 25$ °C, Nominal) (Vd = 7.5V, Id = 650mA ± 5 %)

| Symbol | Parameter | Test Conditions | Тур | Units | Notes |
|--------|--|-------------------|------|-------|-------|
| Gain | Small Signal Gain | F = 12.5 – 16 GHz | 25 | dB | |
| IRL | Input Return Loss | F = 12.5 – 16 GHz | 7 | dB | |
| ORL | Output Return Loss | F = 12.5 – 16 GHz | 10 | dB | |
| PWR | Output Power @ Pin = +14dBm | F = 12.5 – 16 GHz | 33.5 | dBm | |
| PAE | Power Added Efficiency @ Pin = +14dBm | F = 12.5 – 16 GHz | 29 | % | |

Note: Table III Lists the RF Characteristics of typical devices as determined by fixtured measurements.

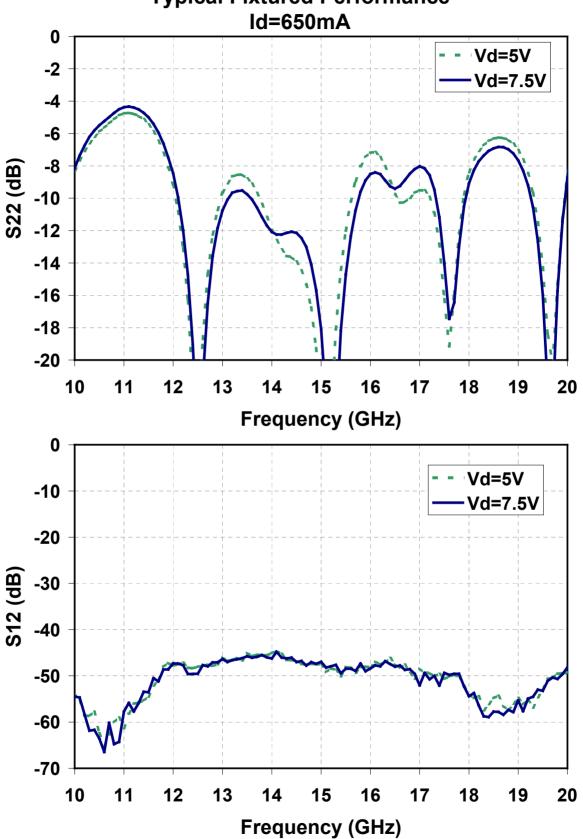


Typical Fixtured Performance TGA2510-EPU-SG





Typical Fixtured Performance TGA2510-EPU-SG

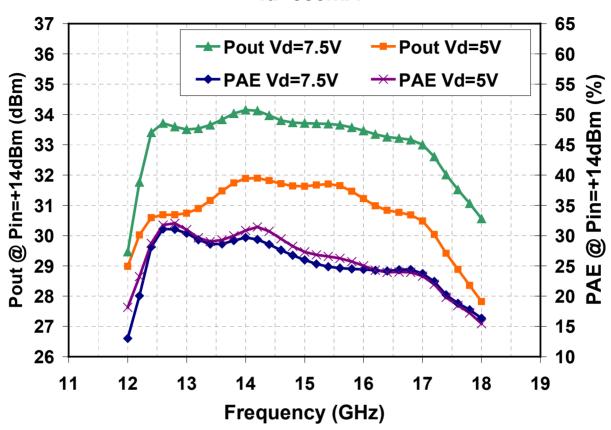






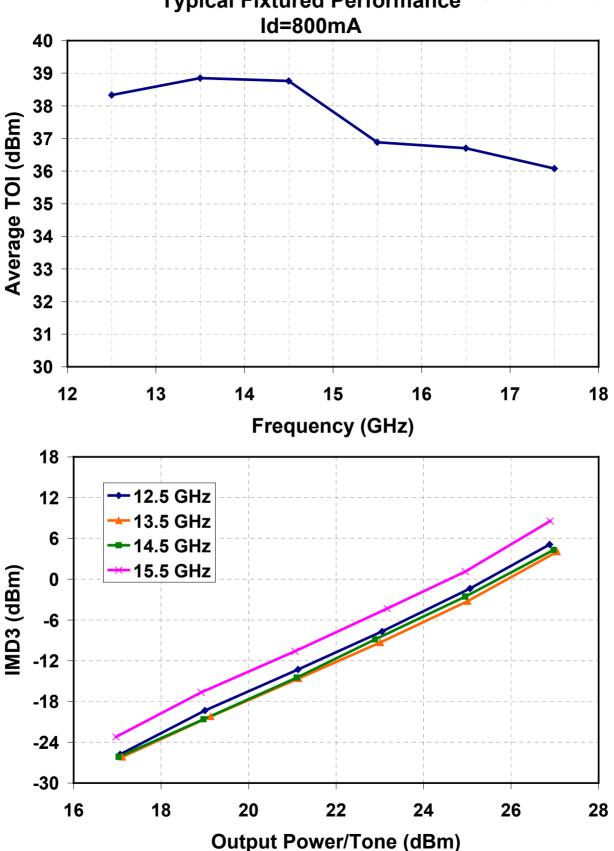
TGA2510-EPU-SG

Typical Fixtured Performance Id=650mA





Typical Fixtured Performance TGA2510-EPU-SG

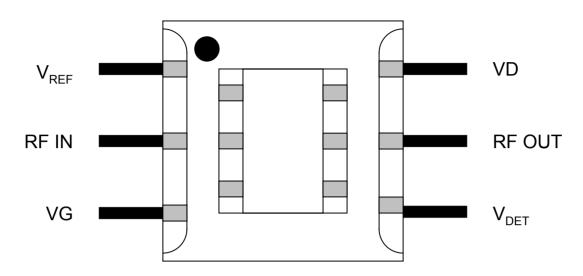




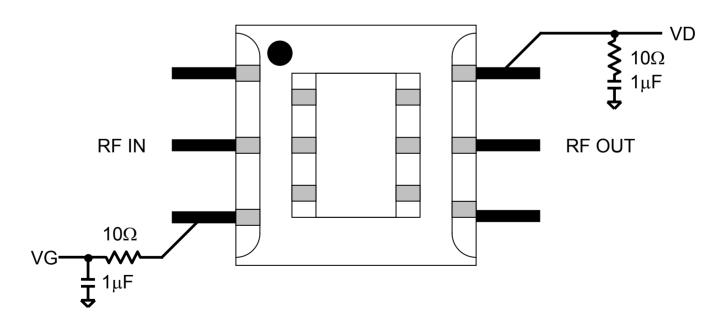


TGA2510-EPU-SG

Package Pinout Diagram



Package Assembly Diagram



GaAs MMIC devices are susceptible to damage from Electrostatic Discharge. Proper precautions should be observed during handling, assembly and test.

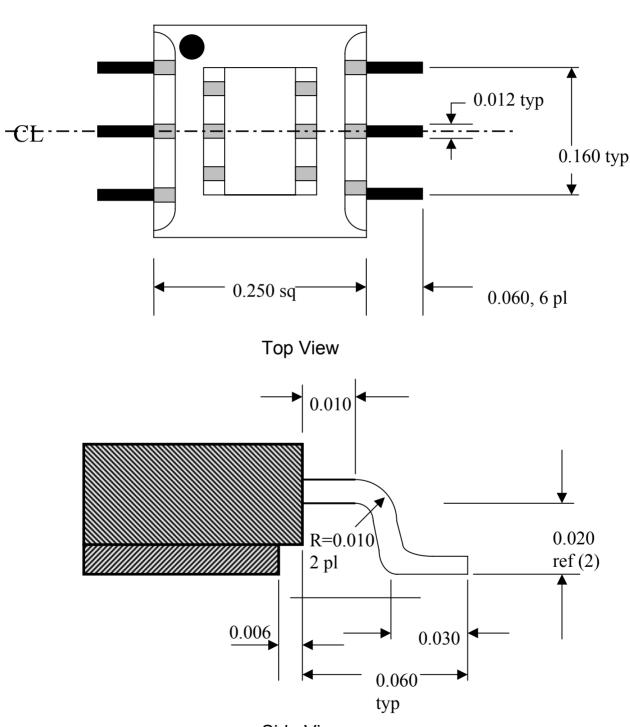


Advance Product Information October 30, 2003

TGA2510-EPU-SG

Mechanical Drawing

Dimensions in inches



Side View

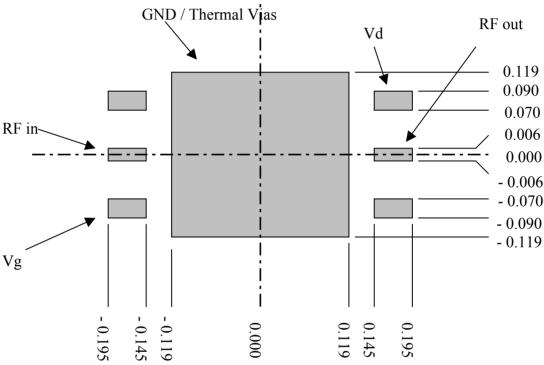


Advance Product Information October 30, 2003

TGA2510-EPU-SG

Recommended PWB Land Pattern

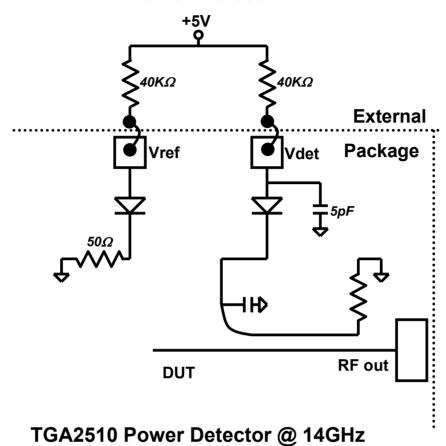
Dimensions in inches

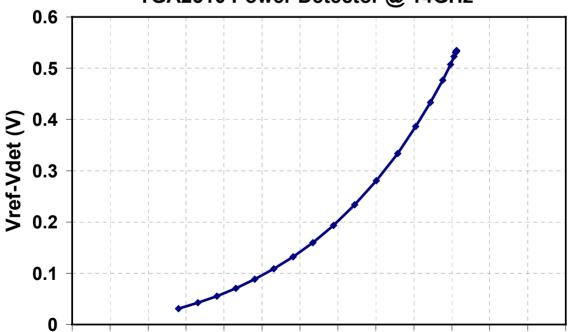




TGA2510-EPU-SG

Power Detector





Note: Devices designated as EPU are typically early in their characterization process prior to finalizing all electrical and process specifications. Specifications are subject to change without notice.

Pout (dBm)